
Uncertainty Quantification for Plasma- and PWI- models

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- Motivation
- Approaches to Uncertainty Quantification
- Example: Vlasov-Poisson-system
- Sensitivity Analysis
- Emulators: Gaussian Processes
- Example: SOLPS-data
- Challenges

Two types of uncertainties (lack of knowledge) are to be distinguished:

- Isolatable uncertainties eg.
 - electron mass
 - cross-sections from first principles
 - ...
- non-isolatable uncertainties
 - most non-trivial simulations eg. climate- or plasma-simulation output
 - complex/integrated data analysis

Verification, Validation and Uncertainty Quantification in a scientific software/modeling context:

- Simulations provide *approximate* solutions to problems for which we do not know the exact solution.

This leads to three more questions:

- How good are the approximations?
- How do you test the software?
- '*Predictive*' power?

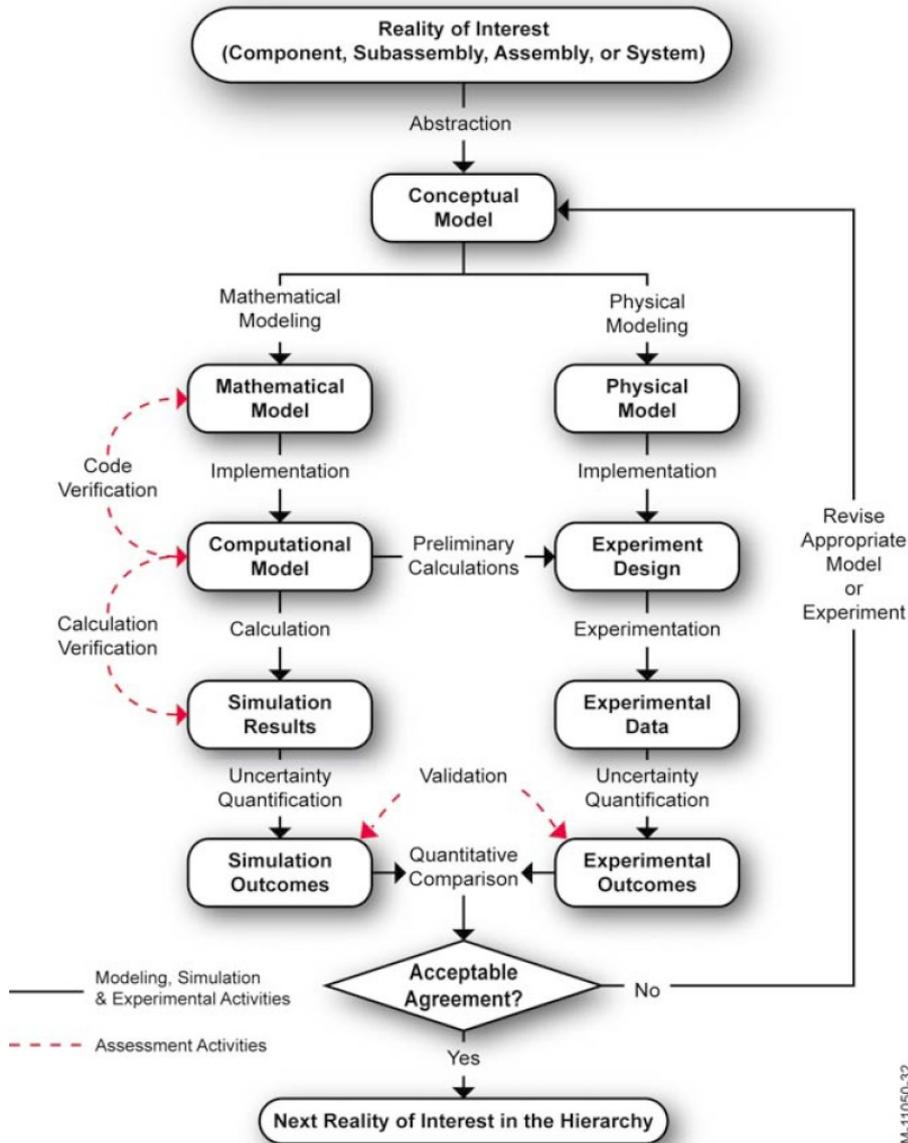
Different Assessment Techniques for Different Sources of Uncertainty or Error

Problem:

- Model(s) not good enough
- Numerics not good enough
 - Algorithm is not implemented correctly
 - Algorithm is flawed
- Problem definition not good enough

Assessment:

- Validation
- Code verification
- Code verification
- Uncertainty quantification

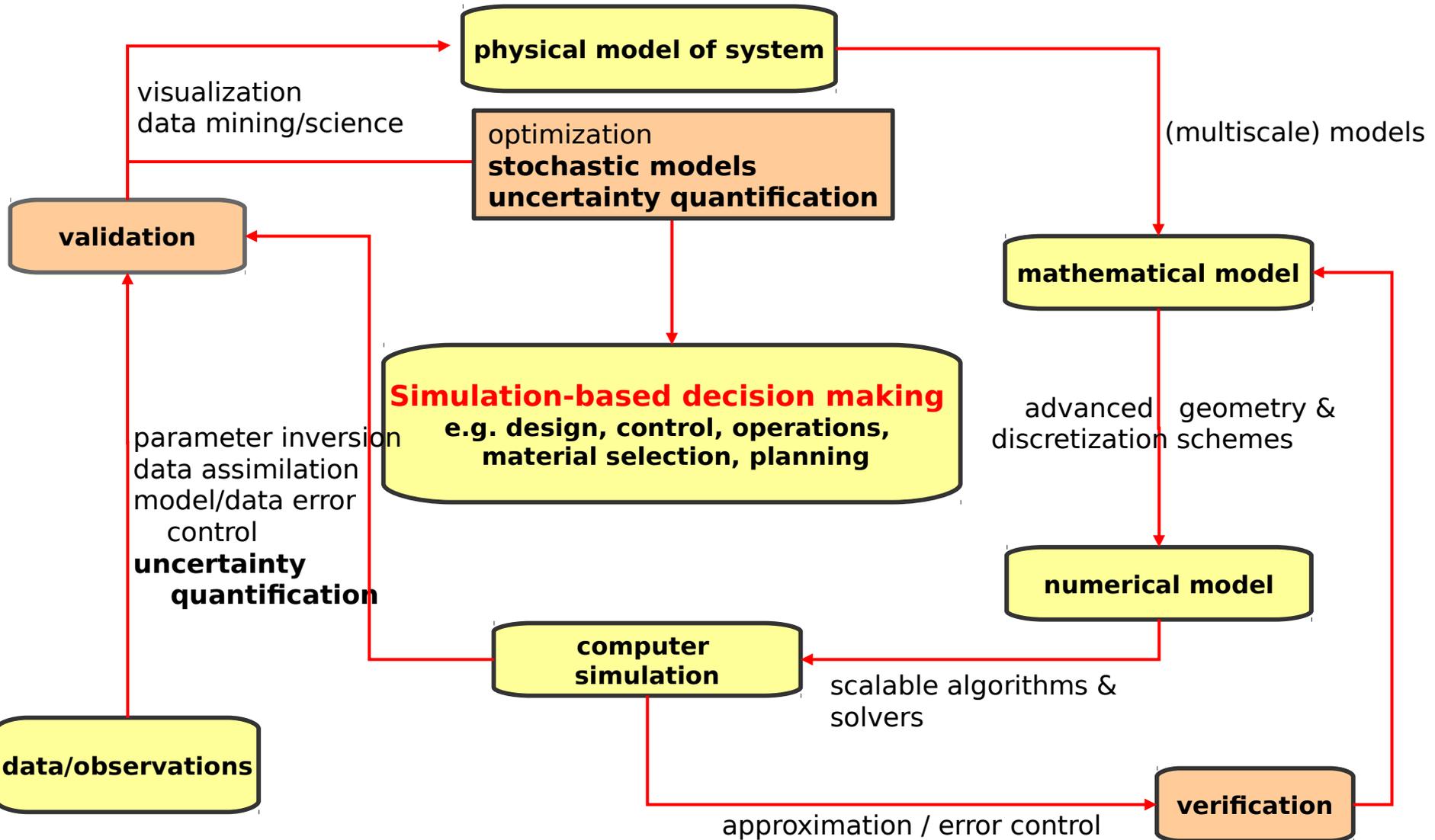


Recognized in many other (engineering) fields
Example:

V&V process flowchart from the ASME Solid Mechanics V&V guide (2006).

May be too simplistic...

Motivation: Design Cycle



- **Systematic Uncertainty Quantification in Plasma Physics**

- Often still at the very beginning (parameter scans)
- Importance increasingly realized ('shortfall'): V&V&UQ
- connection with 'surrogate' models

Setting up a reference case based on relevant, non-trivial and well understood system in plasma physics:

Vlasov-Poisson-Model

- Phase-space distribution function $f(\mathbf{x}, \mathbf{v})$ of collisionless plasma:

$$\frac{\partial f}{\partial t} + \mathbf{v} \cdot \frac{\partial f}{\partial \mathbf{x}} + \frac{q}{m} (\mathbf{E} + \mathbf{v} \times \mathbf{B}) \cdot \frac{\partial f}{\partial \mathbf{v}} = 0$$

$$\rho(\mathbf{x}, t) = q \int f(\mathbf{x}, \mathbf{v}, t) d\mathbf{v}$$

$$\mathbf{J}(\mathbf{x}, t) = q \int f(\mathbf{x}, \mathbf{v}, t) \mathbf{v} d\mathbf{v}$$

$$\nabla \times \mathbf{B} = \mathbf{J}$$

$$\nabla \times \mathbf{E} = 0$$

$$\nabla \cdot \mathbf{E} = \frac{\rho}{\epsilon_0}$$

$$\nabla \cdot \mathbf{B} = 0$$

$$-\Delta \phi = 1 - \rho(t, \mathbf{x}) = 1 - q \int f(t, \mathbf{x}, \mathbf{v}) d\mathbf{v}$$

$$\mathbf{E} = -\nabla \phi \quad .$$

- Phase-space distribution function $f(x,v,t)$ of collisionless plasma:

$$\frac{\partial f}{\partial t} + \mathbf{v} \cdot \frac{\partial f}{\partial \mathbf{x}} + \frac{q}{m} (\mathbf{E} + \mathbf{v} \times \mathbf{B}) \cdot \frac{\partial f}{\partial \mathbf{v}} = 0$$

System details:

- 1+1-dimensional (x,v -space)
- Solver: Semi-Lagrangian-solver
- Boundary conditions: periodic
- Negligible \mathbf{B} -field contributions
- Static ion-background
- External **random** E-field contribution $\mathbf{E}_0(x)$

Effect of the random E-field?

Methods applied in Uncertainty Quantification

- Sampling

- Spectral Expansion
 - Galerkin Approach
 - Stochastic Collocation
 - Discrete Projection

- Surrogate models (eg. Gaussian processes)

➤ Sampling approach

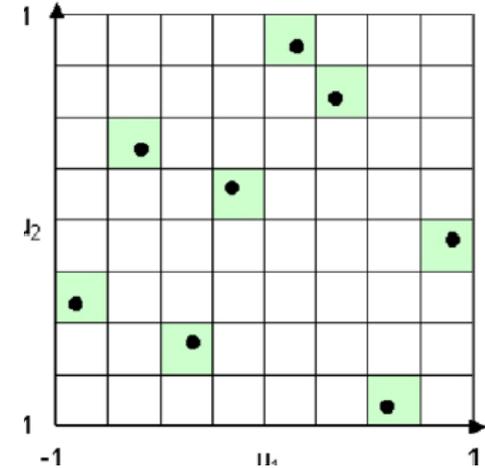
Use random sample $S = \{\mathbf{x}^{(i)}, i=1, \dots, N\}$

to compute distribution $p(\mathbf{y})$ and moments :

$$\langle y_j \rangle = \frac{1}{N} \sum_{i=1}^N M(x^i)_j$$

$$\text{var}(y) = \langle y^2 \rangle - \langle y \rangle^2$$

+ higher order terms....



Advantages: - Includes all correlations (→ verification)

- Parallel & straightforward

Downside: - sample point density: **curse of dimensions**: $\rho \sim \rho_0^{-\text{Dim}}$

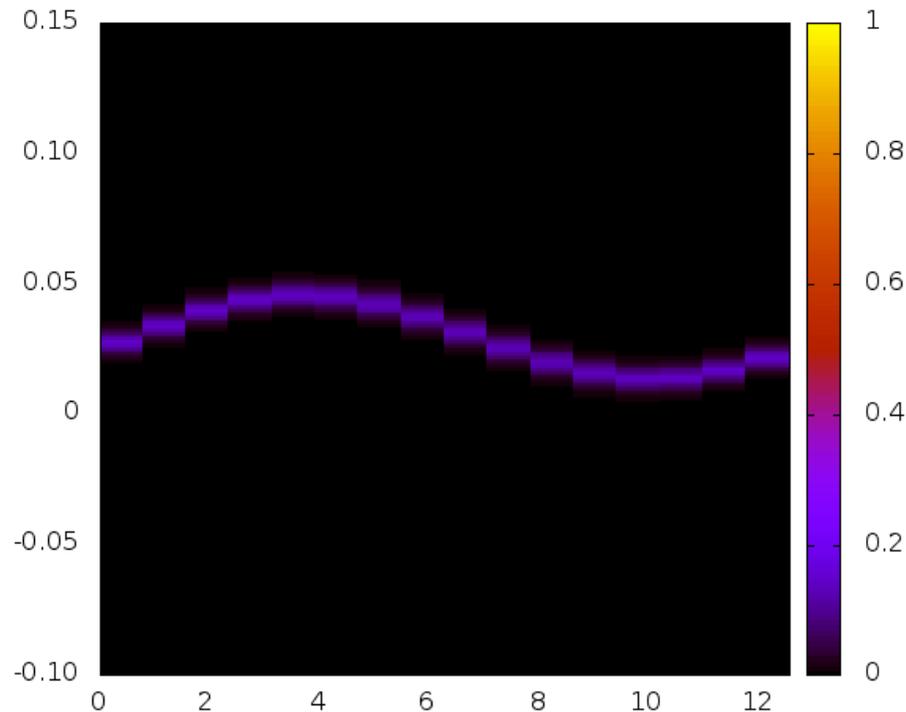


➤ Sampling approach

Example: Vlasov-Poisson, random external field $E = E_0 + N(\mu=0, \sigma=0.1E_0)$

t=0.4 s

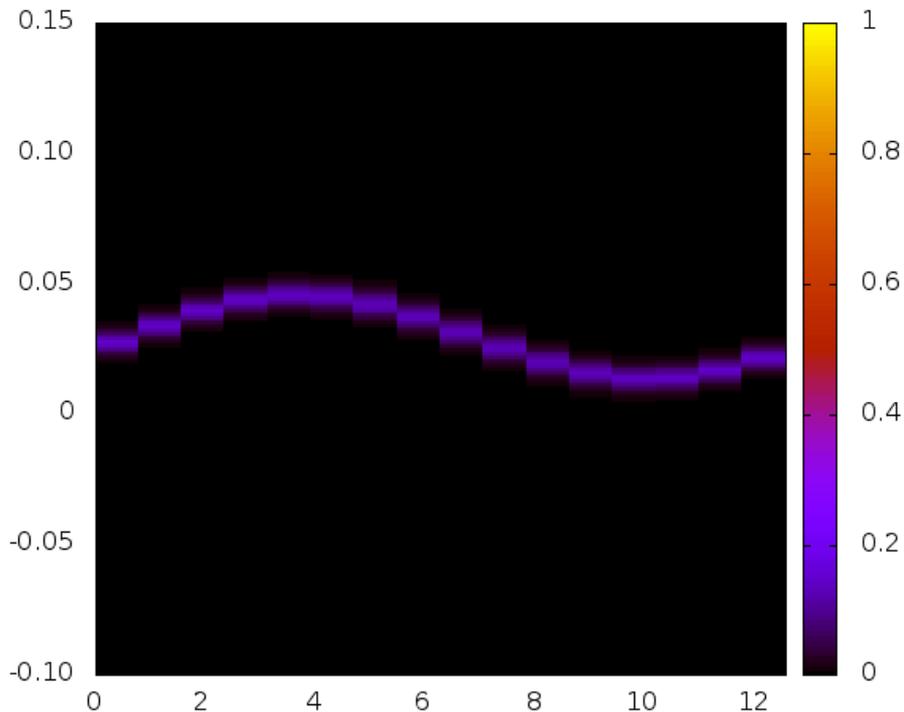
t=2.8 s



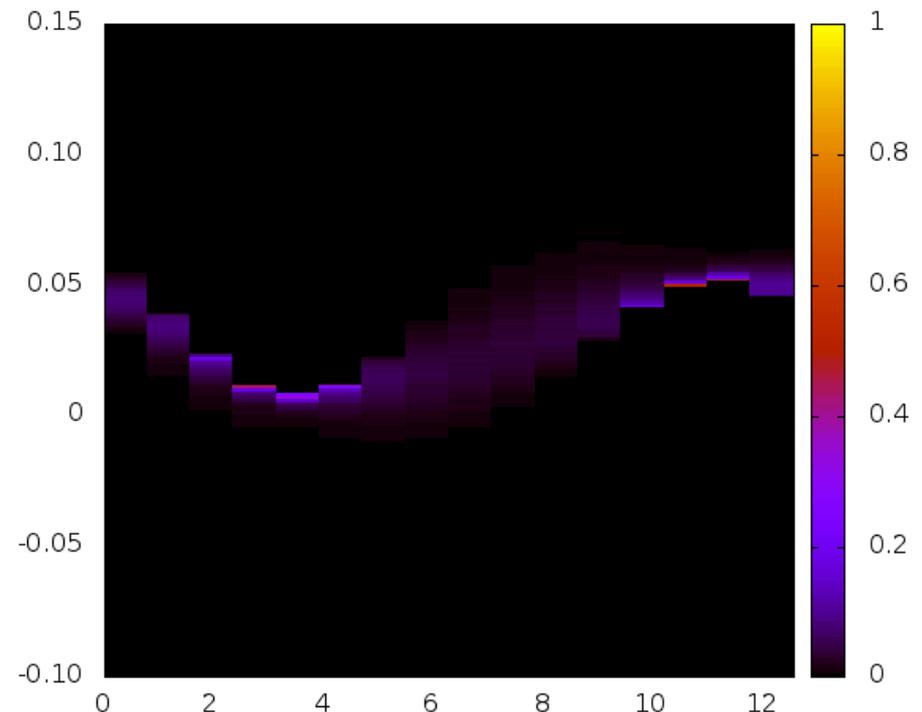
➤ Sampling approach

Example: Vlasov-Poisson, random external field $E = E_0 + N(\mu=0, \sigma=0.1E_0)$

t=0.4 s



t=2.8 s



➤ Spectral Expansion (Polynomial chaos expansion)

- Consider a computational model $\mathcal{M} : \mathcal{D} \subset \mathbb{R}^M \mapsto \mathbb{R}$ and a probabilistic model for the uncertainty in the input parameters, say $\mathbf{X} \sim f_{\mathbf{X}}(\mathbf{x}) = \prod_{i=1}^M f_{X_i}(x_i)$.
- Assuming that $\mathbb{E} [\mathcal{M}(\mathbf{X})^2] < \infty$ one can represent the random response $Y = \mathcal{M}(\mathbf{X})$ in a suitable Hilbert space.
- There exists a countable orthonormal basis $\{\psi_j, j \in \mathbb{N}\}$ such that :

$$Y = \sum_{j=0}^{\infty} y_j \Psi_j(\mathbf{X})$$

where :

- y_j : coefficients to be computed (coordinates)
- Ψ_j : basis functions e.g. multivariate orthonormal polynomials

➤ Spectral Expansion

Two different approaches:

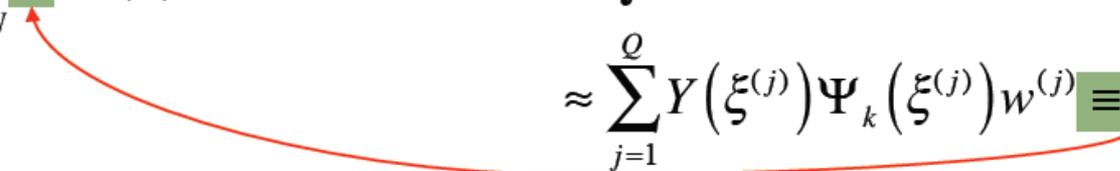
- **Intrusive methods** depend on the formulation and solution of a *stochastic* version of the original model
- **Nonintrusive** methods require **multiple** solutions of the **original** (deterministic) model only

➤ Spectral Expansion - Non-intrusive I

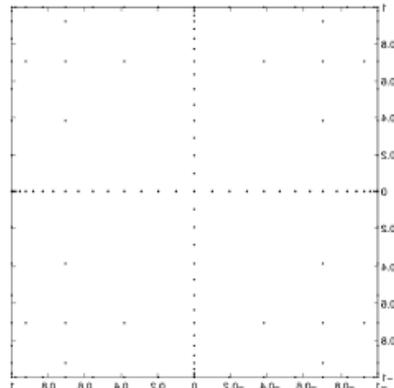
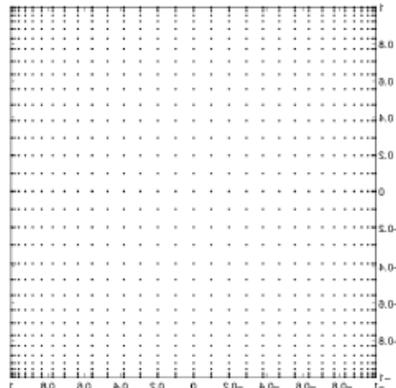
• Stochastic Collocation

- No need to reformulate governing equations (“non-intrusive”)
- *gPC-based pseudospectral approach:*

Seek $\tilde{Y}_N(\xi) = \sum_{|k|<N} \tilde{a}_k \Psi_k(\xi)$ by computing $a_k = \int Y(\xi) \Psi_k(\xi) \rho(\xi) d\xi$

$$\approx \sum_{j=1}^Q Y(\xi^{(j)}) \Psi_k(\xi^{(j)}) w^{(j)} \equiv \tilde{a}_k$$


- Quadrature rule $\{\xi^{(j)}, w^{(j)}\}_{j=1}^Q$ can be **sparse** (e.g., Smolyak)



➤ Spectral Expansion - Non-intrusive I

➤ Computation of multi-dim integrals:

- exploit structure (Gaussian $p(\xi)$): Gauss-Hermite quadrature

$$Y(\xi) = \sum_{k=0}^P a_k \psi_k(\xi) \quad \text{with} \quad a_k = \frac{\langle Y(\xi), \psi_k(\xi) \rangle}{\langle \psi_k(\xi), \psi_k(\xi) \rangle}$$

$$\langle h_1(\xi), h_2(\xi) \rangle = \int h_1(\xi) h_2(\xi) p(\xi) d\xi \stackrel{\text{G.H.}}{=} \sum_{l=1}^L h_1(\xi_l) h_2(\xi_l) w_l$$

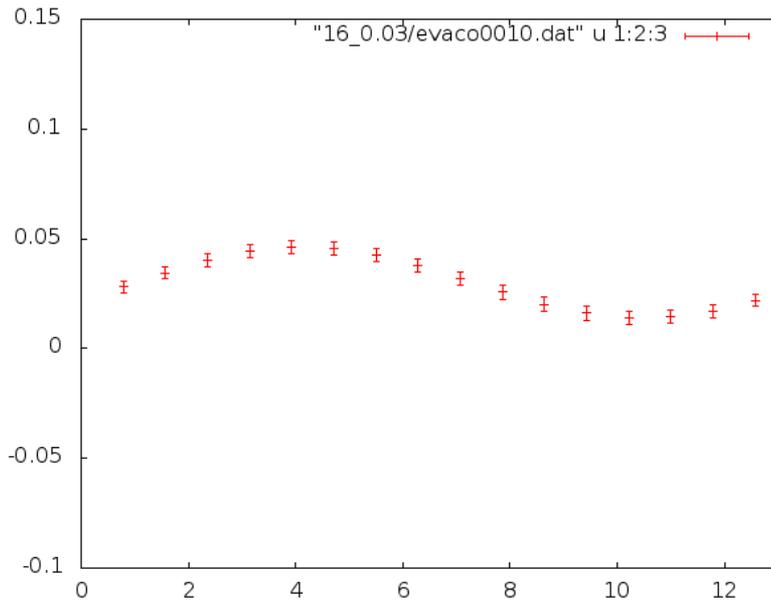
➡ Mean $\langle Y \rangle = a_0$ and variance σ^2 :

$$\sigma_R = \mathcal{E}(R^2) - \mathcal{E}(R)^2 = \sum_{k=1}^P a_k^2 \langle \psi_k, \psi_k \rangle = \sum_{k=1}^P a_k^2 k!$$

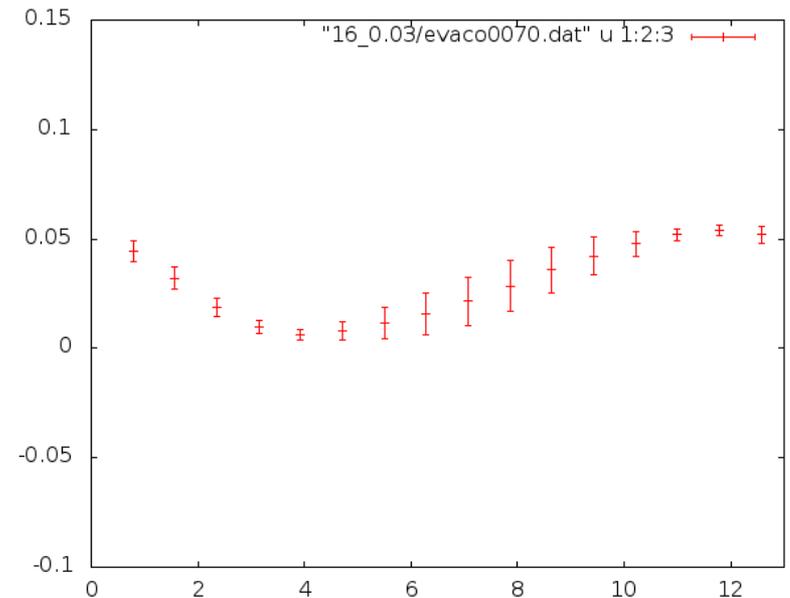
➤ Spectral Expansion - Non-intrusive I

Example: Vlasov-Poisson, random external field $E = E_0 + N(\mu=0, \sigma=0.1E_0)$

t=0.4 s



t=2.8 s



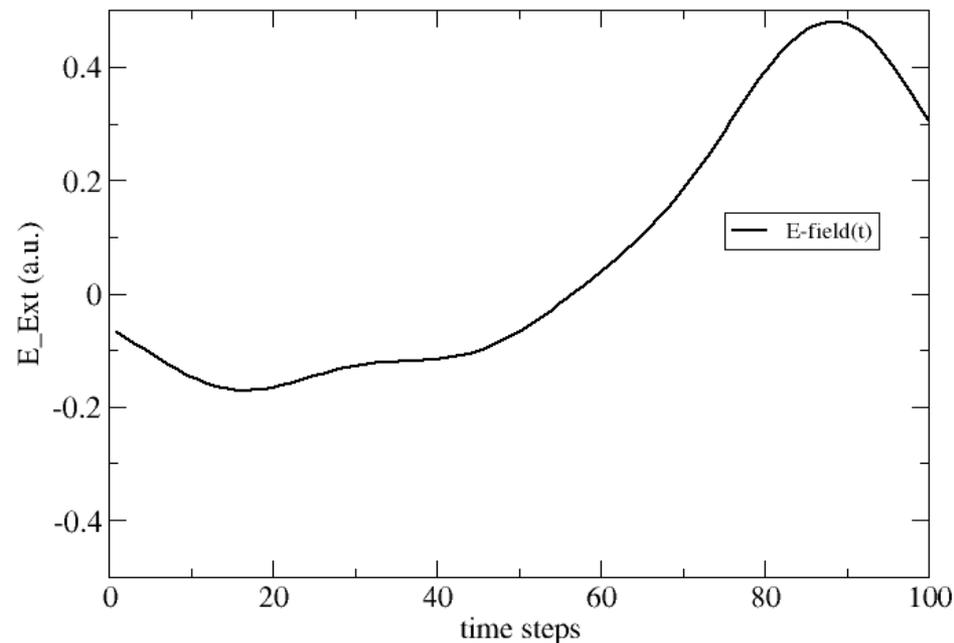
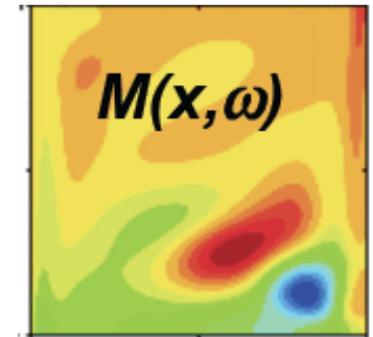
4-th order expansion in excellent agreement with MC in fraction of computing time

➤ Spectral Expansion - Non-intrusive II

Now: **Random field** $M(x,t)$ instead of random variable(s)

Infinite number of random variables ??

Example: E-field fluctuation



- **Covariance matrix:** correlation length essential:
➔ no white noise!

$$C_{ij} = \exp \left\{ -\frac{1}{2} \frac{(t_i - t_j)^2}{\lambda^2} \right\}$$

- Let $M \sim GP(\mu, C)$
- Introduce the **Karhunen-Loève expansion** & truncate:

$$M(\mathbf{x}, \omega) = \mu(\mathbf{x}) + \sum_{i=1}^K \sqrt{\lambda_i} c_i(\omega) \phi_i(\mathbf{x})$$

- λ_i and $\phi_i(\mathbf{x})$ are eigenvalues/eigenfunctions of $C(\mathbf{x}_1, \mathbf{x}_2)$

$$\int_D C(\mathbf{x}_1, \mathbf{x}_2) \phi_i(\mathbf{x}_2) d\mathbf{x}_2 = \lambda_i \phi_i(\mathbf{x}_1)$$

- $c_i \sim N(0, 1)$

- Transform the inverse problem (**dim = $K \ll n$**)

$$d = \tilde{G}(\mathbf{c}) + \eta$$

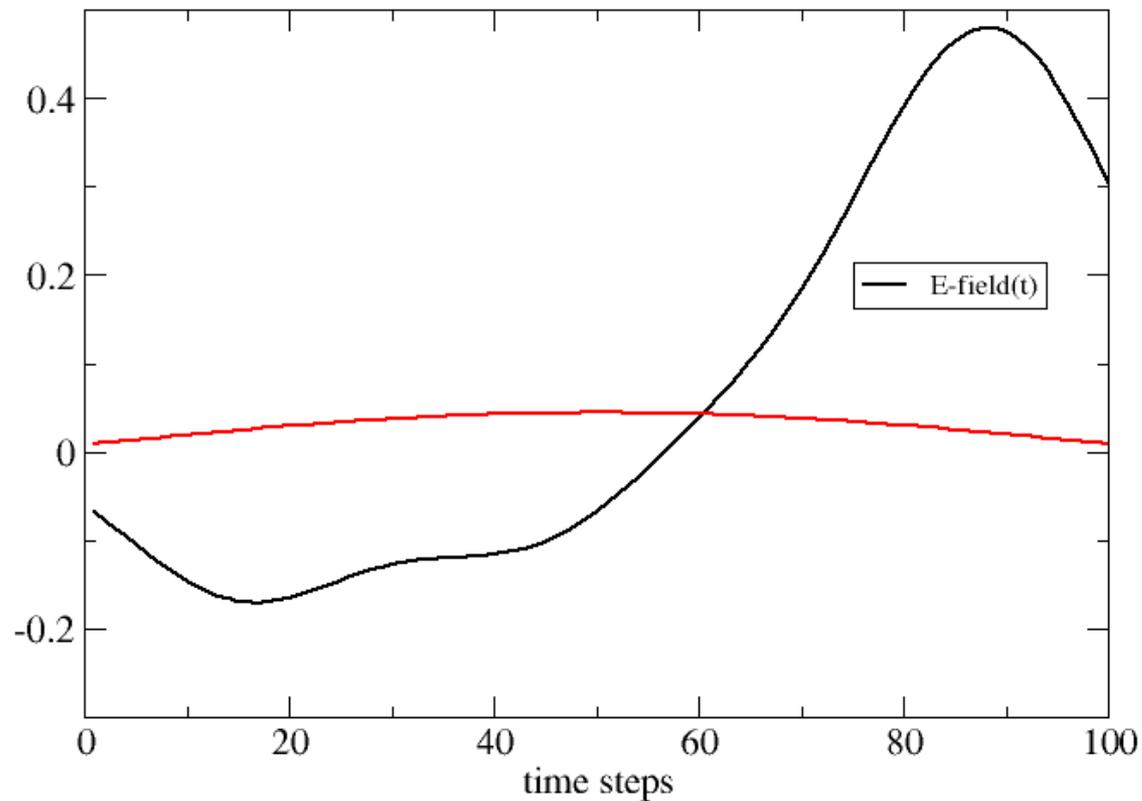
➤ **I) Covariance matrix:**

$$C_{ij} = \exp \left\{ -\frac{1}{2} \frac{(t_i - t_j)^2}{\lambda^2} \right\}$$

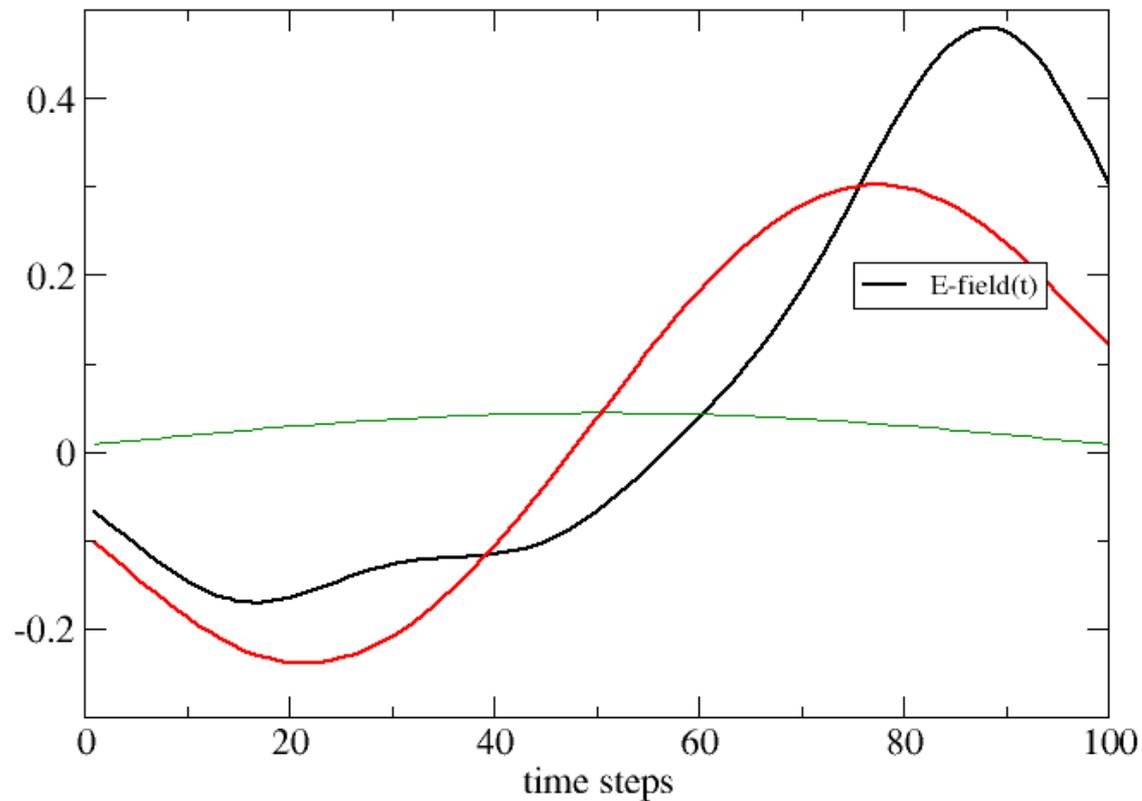
Eigenvectors

Eigenvalues

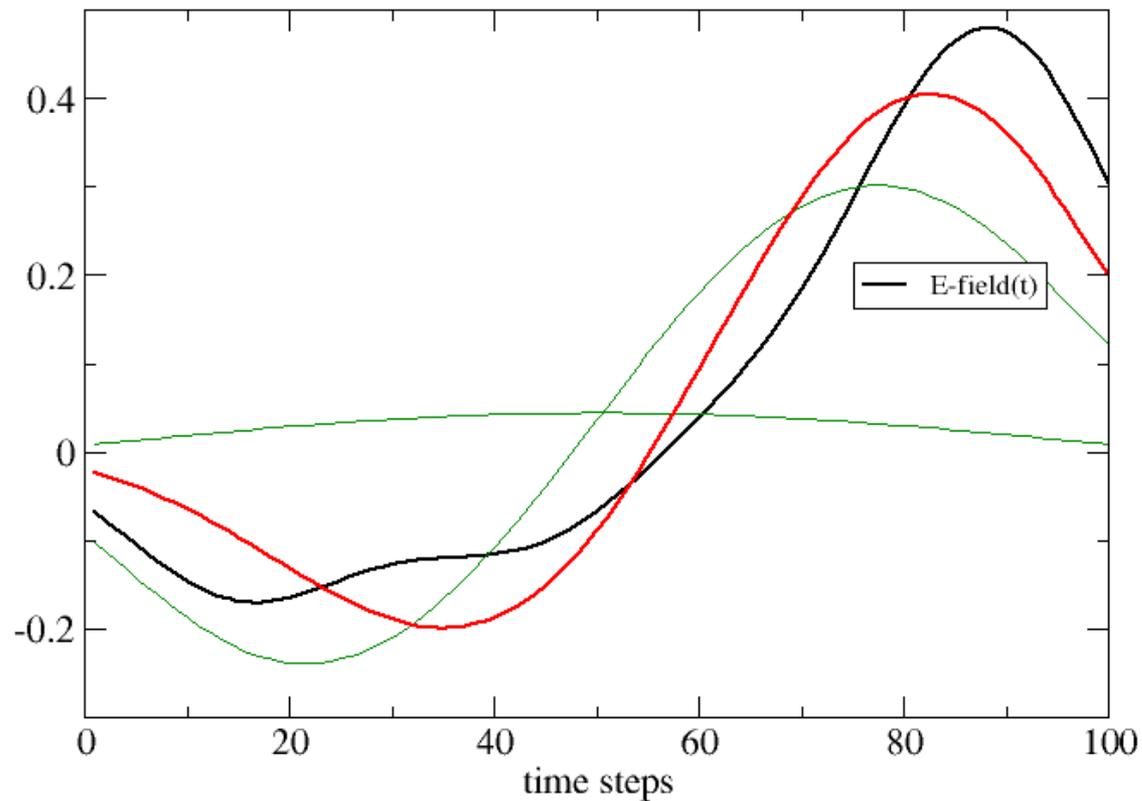
➤ Expansion of random field in KL-representation



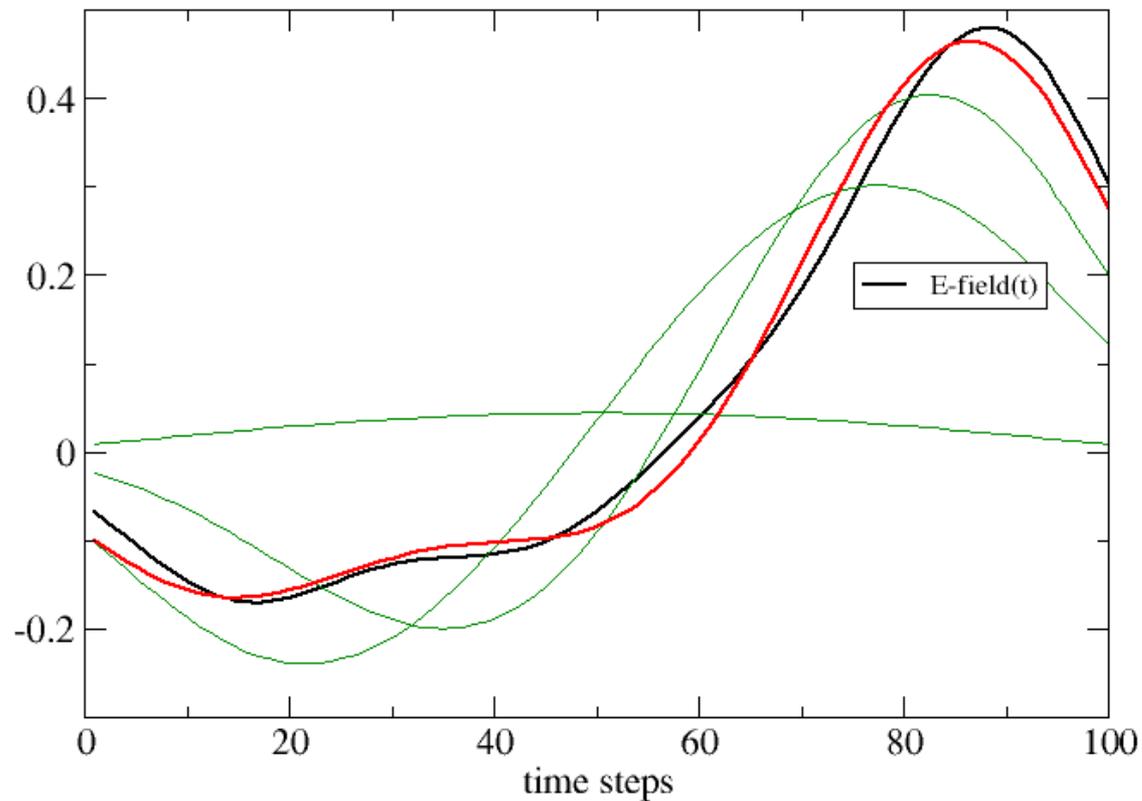
➤ Expansion of random field in KL-representation



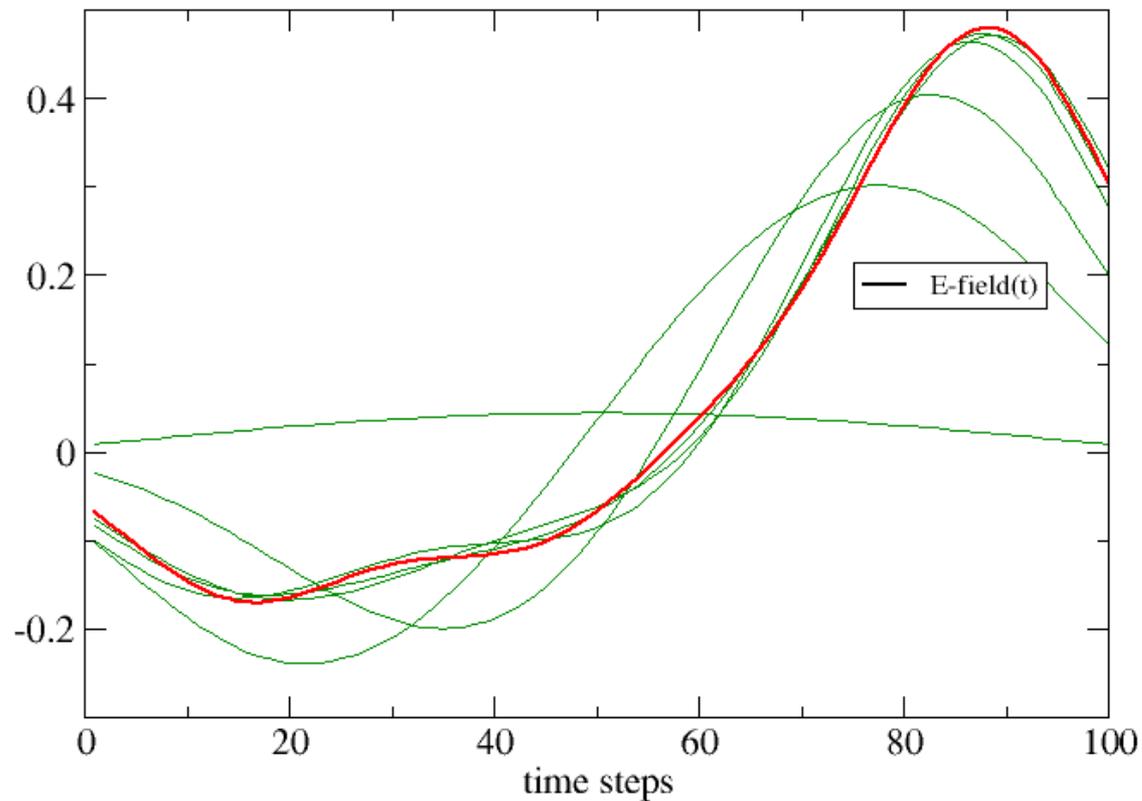
➤ Expansion of random field in KL-representation



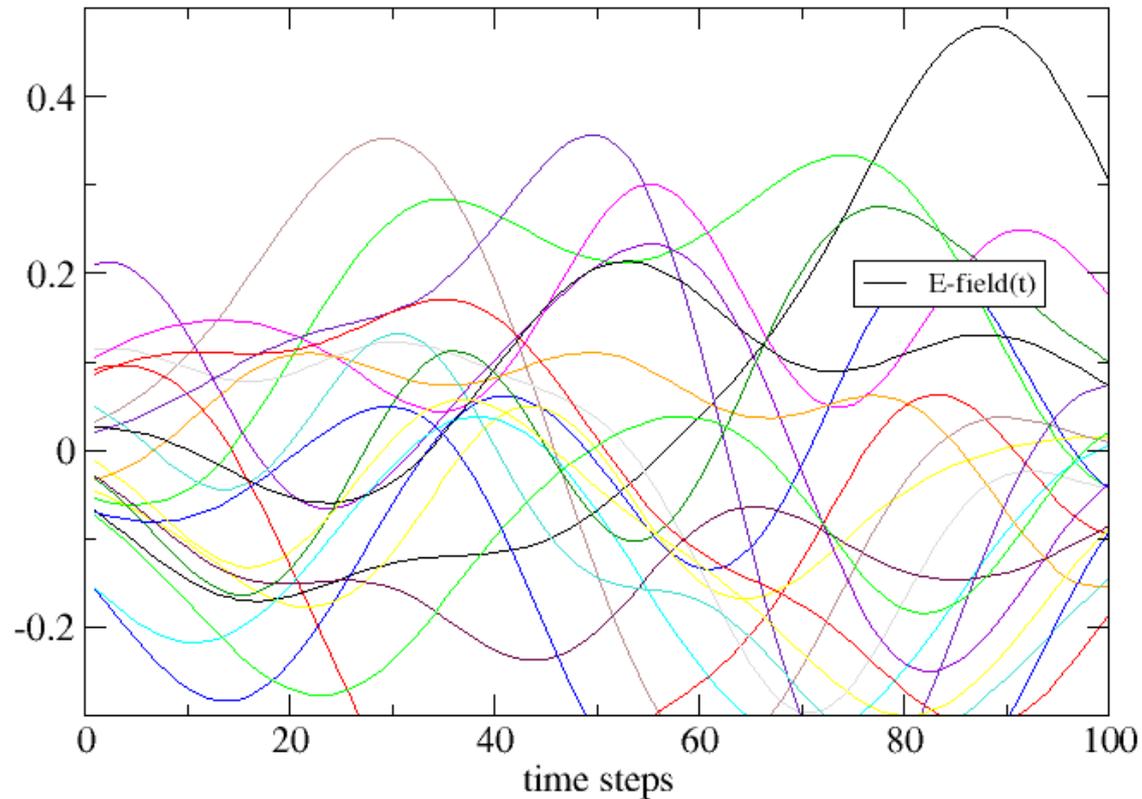
➤ Expansion of random field in KL-representation



➤ Expansion of random field in KL-representation



➤ Random samples of random field in KL-representation



- Vlasov-Poisson with fluctuating external E-field: Uncertainty?
- Now multivariate Gauss-Hermite integration:

$$a_k = \frac{1}{k!} \int \dots \int d\xi_1 \dots d\xi_M g(\xi_1, \dots, \xi_M) \psi_k(\xi_1, \dots, \xi_M) p(\xi_1, \dots, \xi_M)$$

j	α	$\Psi_\alpha \equiv \Psi_j$
0	[0, 0]	$\Psi_0 = 1$
1	[1, 0]	$\Psi_1 = \xi_1$
2	[0, 1]	$\Psi_2 = \xi_2$
3	[2, 0]	$\Psi_3 = (\xi_1^2 - 1)/\sqrt{2}$
4	[1, 1]	$\Psi_4 = \xi_1 \xi_2$
5	[0, 2]	$\Psi_5 = (\xi_2^2 - 1)/\sqrt{2}$
6	[3, 0]	$\Psi_6 = (\xi_1^3 - 3\xi_1)/\sqrt{6}$
7	[2, 1]	$\Psi_7 = (\xi_1^2 - 1)\xi_2/\sqrt{2}$
8	[1, 2]	$\Psi_8 = (\xi_2^2 - 1)\xi_1/\sqrt{2}$
9	[0, 3]	$\Psi_9 = (\xi_2^3 - 3\xi_2)/\sqrt{6}$

Example: $M=2, P=3$

$$\begin{aligned} \tilde{Y} \equiv \mathcal{M}^{\text{PC}}(\xi_1, \xi_2) = & a_0 + a_1 \xi_1 + a_2 \xi_2 \\ & + a_3 (\xi_1^2 - 1)/\sqrt{2} + a_4 \xi_1 \xi_2 \\ & + a_5 (\xi_2^2 - 1)/\sqrt{2} + a_6 (\xi_1^3 - 3\xi_1)/\sqrt{6} \\ & + a_7 (\xi_1^2 - 1)\xi_2/\sqrt{2} + a_8 (\xi_2^2 - 1)\xi_1/\sqrt{2} \\ & + a_9 (\xi_2^3 - 3\xi_2)/\sqrt{6} \end{aligned}$$

$$N_{\text{int}} = \frac{(M + P)!}{M!P!}$$

Partial variance

- Consider :

$$D_{i_1 \dots i_s} = \int_{[0,1]^s} \mathcal{M}_{i_1 \dots i_s}^2(x_{i_1}, \dots, x_{i_s}) dx_{i_1} \dots dx_{i_s}$$

- Then :

$$D = \sum_{i=1}^M D_i + \sum_{1 \leq i < j \leq M} D_{ij} + \dots + D_{12 \dots M}$$

- The Sobol' indices are obtained by normalization :

$$S_{i_1 \dots i_s} = \frac{D_{i_1 \dots i_s}}{D}$$

They represent the fraction of the total variance $\text{Var}[Y]$ that can be attributed to each input variable i (S_i) or combinations of variables $\{i_1 \dots i_s\}$

Sensitivity Assessment: Example

Computational model

$$Y = \mathcal{M}(X_1, X_2)$$

Probabilistic model

$$X_i \sim \mathcal{N}(\mu_i, \sigma_i) \quad i = 1, 2$$

Isoprobabilistic transform

$$X_i = \mu_i + \sigma_i \xi_i \quad i = 1, 2$$

Chaos degree

$$p = 3, \text{ i.e. } P = 10 \text{ terms}$$

j	α	$\Psi_\alpha \equiv \Psi_j$
0	[0, 0]	$\Psi_0 = 1$
1	[1, 0]	$\Psi_1 = \xi_1$
2	[0, 1]	$\Psi_2 = \xi_2$
3	[2, 0]	$\Psi_3 = (\xi_1^2 - 1)/\sqrt{2}$
4	[1, 1]	$\Psi_4 = \xi_1 \xi_2$
5	[0, 2]	$\Psi_5 = (\xi_2^2 - 1)/\sqrt{2}$
6	[3, 0]	$\Psi_6 = (\xi_1^3 - 3\xi_1)/\sqrt{6}$
7	[2, 1]	$\Psi_7 = (\xi_1^2 - 1)\xi_2/\sqrt{2}$
8	[1, 2]	$\Psi_8 = (\xi_2^2 - 1)\xi_1/\sqrt{2}$
9	[0, 3]	$\Psi_9 = (\xi_2^3 - 3\xi_2)/\sqrt{6}$

Variance

$$D = \sum_{j=1}^9 a_j^2$$

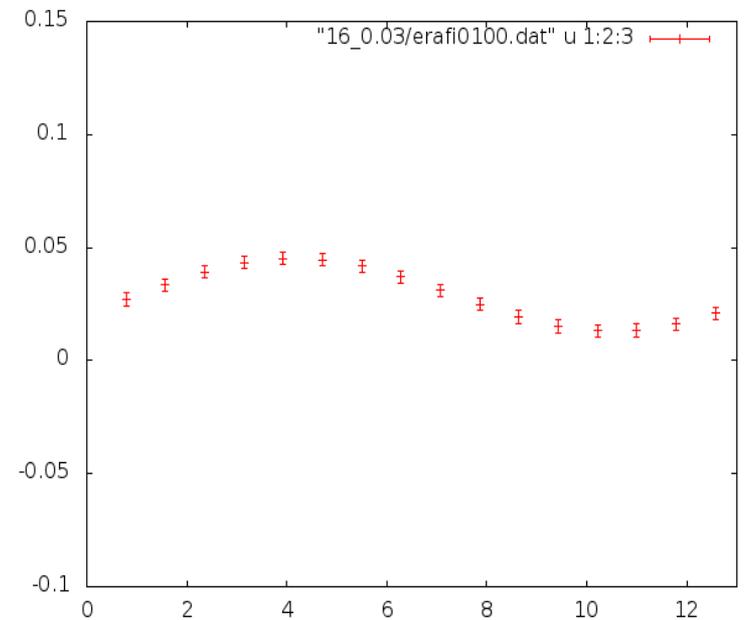
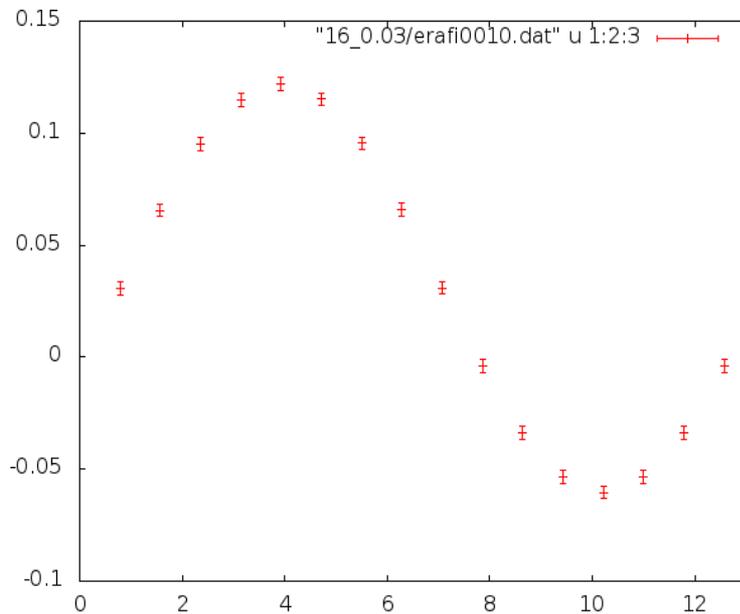
Sobol' indices

$$S_1 = (a_1^2 + a_3^2 + a_6^2) / D$$

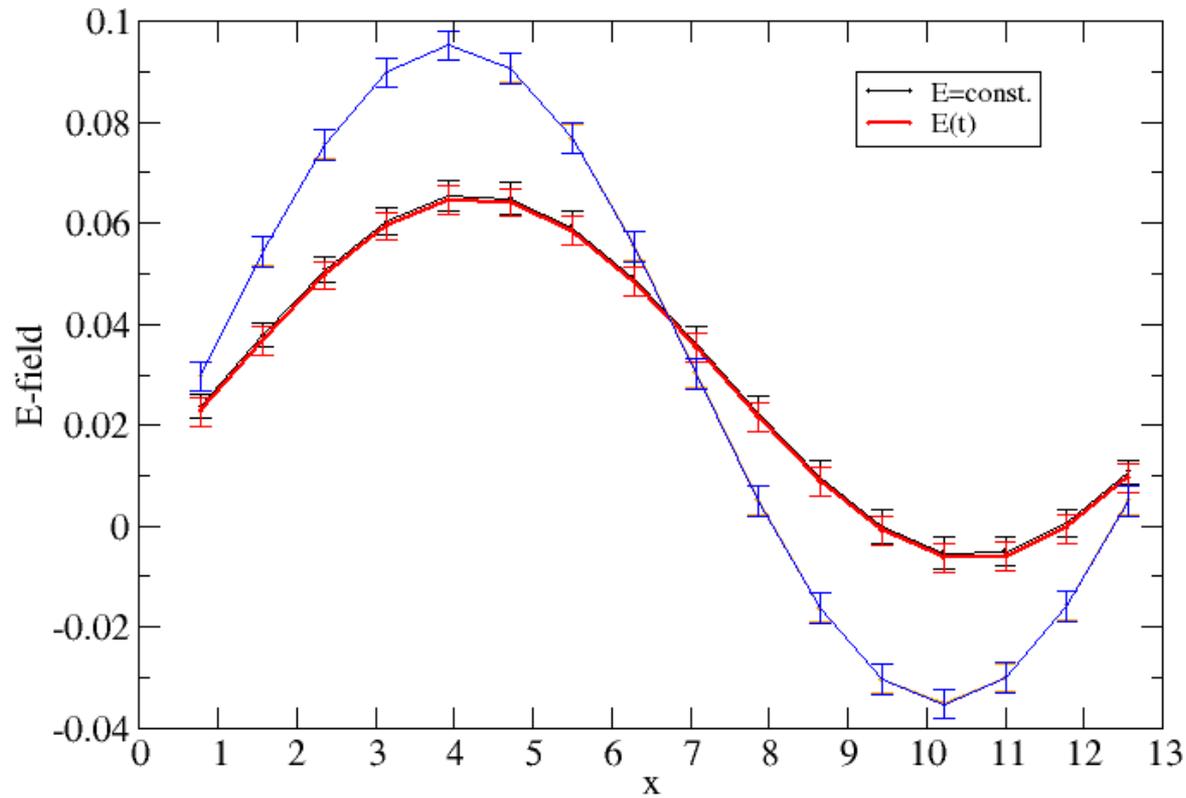
$$S_2 = (a_2^2 + a_5^2 + a_9^2) / D$$

$$S_{12} = (a_4^2 + a_7^2 + a_8^2) / D$$

- Vlasov-Poisson with fluctuating external E-field: all gentle...
- Initial E-field amplitude more important than E-field variation



- Vlasov-Poisson with fluctuating external E-field



➤ **Spectral expansion approach**

- intrusive methods: best (only?) suited for new codes
- non-intrusive methods: general purpose approach
 - selection of collocation points
 - sparse methods for larger problems possible
 - influence of input parameter combinations as byproduct: Sobol decomposition

➤ Proof of principle for 1+1 Vlasov-Poisson Equation

➤ Validated against MC-approach (and other test cases)

➤ Some implementations: eg. DAKOTA

• **Best suited for medium number of dimensions ($O(10)$) and moderately expensive simulators (forward models)**

What if conditions for Spectral expansion do *not* hold?

⇒ Use of *emulators* as surrogate for *simulators*

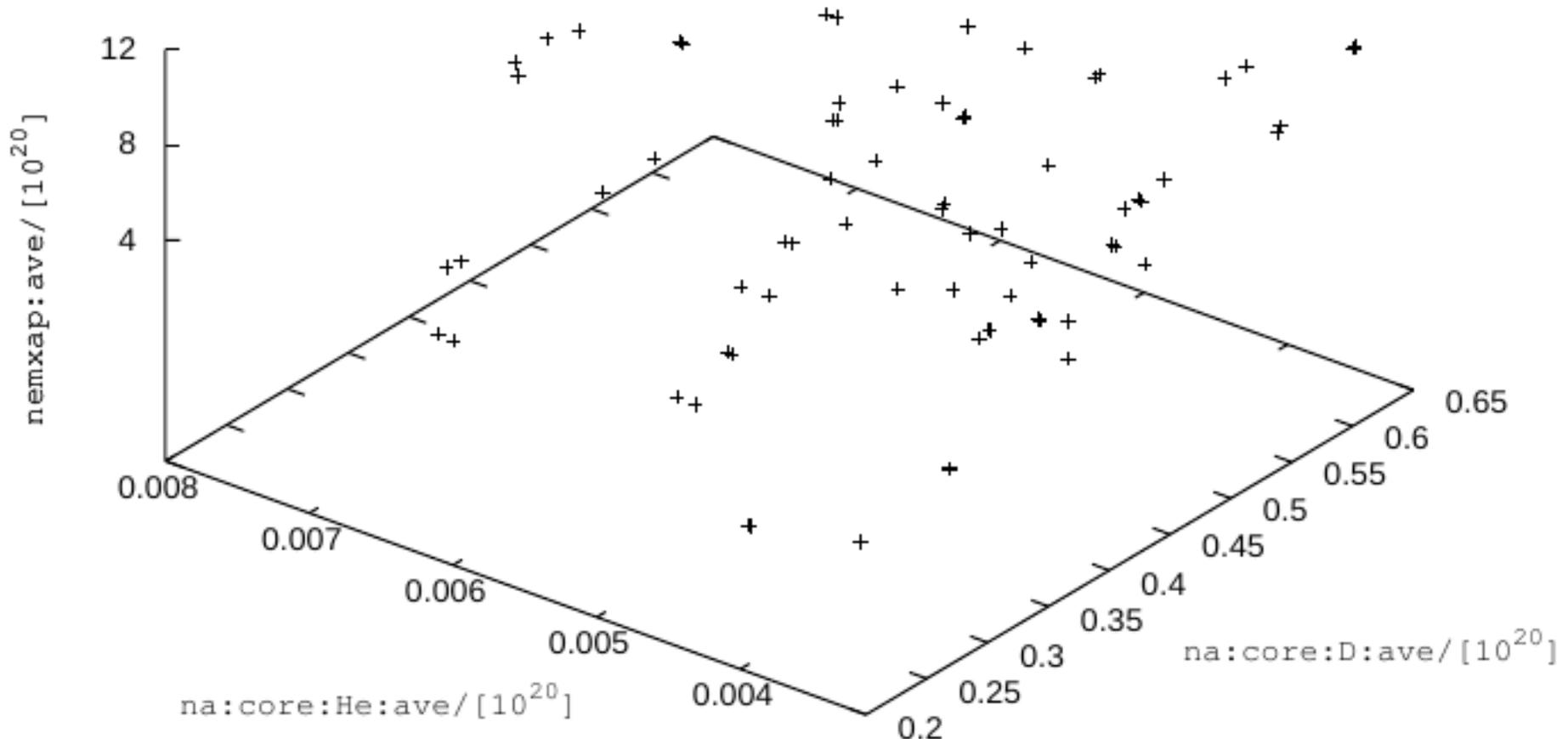
- ▶ A simulator is a model of a real process
 - ▶ Typically implemented as a computer code
 - ▶ Think of it as a function taking inputs x and giving outputs y :


```
graph LR; x --> Code[Code]; Code --> y["y(x)"]
```
- ▶ An emulator is a statistical representation of this function
 - ▶ Expressing knowledge/beliefs about what the output will be at any given input(s)
 - ▶ Built using prior information and a **training set** of model runs

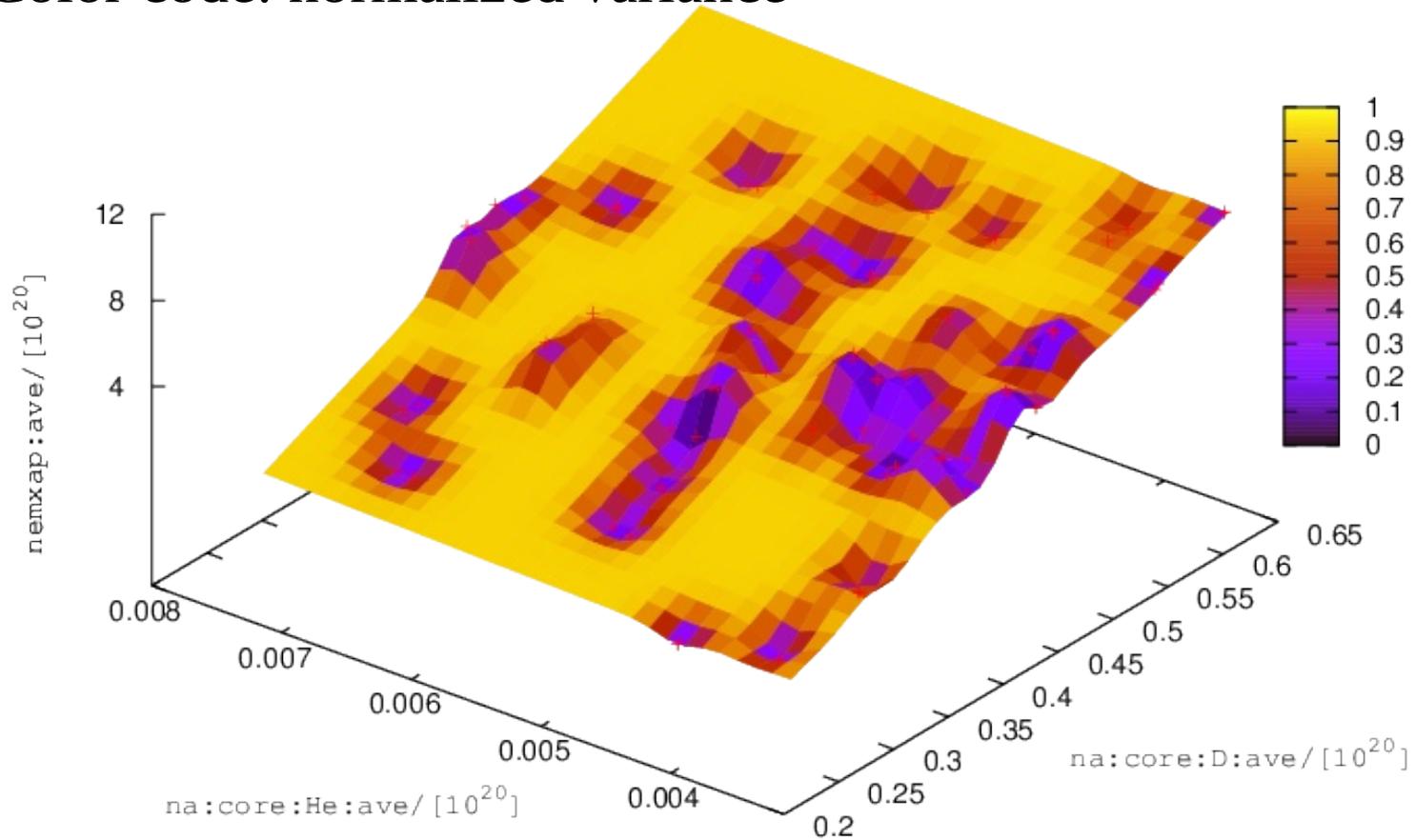
⇒ Focus on *Gaussian Processes*

SOLPS-Data base: - 1500 parameters
- collected by D. Coster

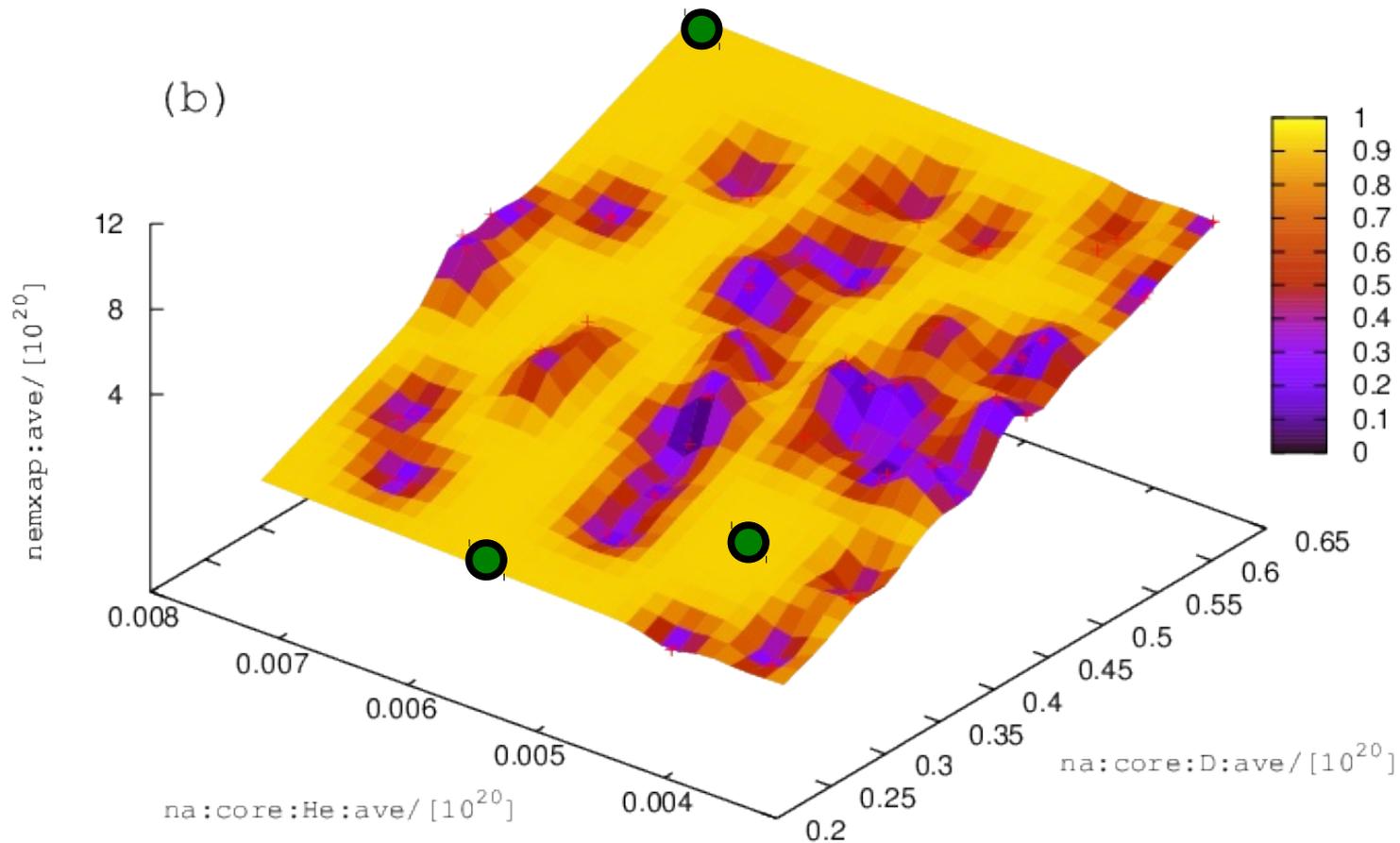
Idea: exploit for initialization, scans



- Result of GP-interpolation
- Color code: normalized variance



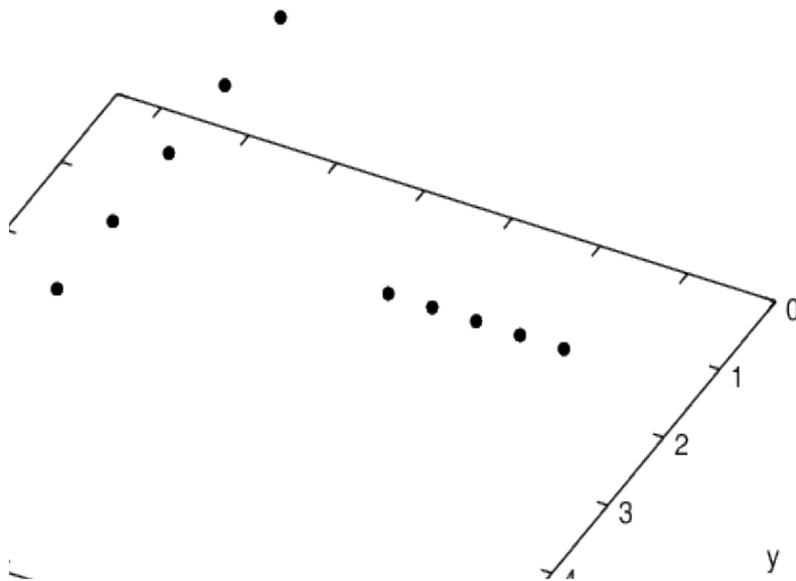
Input-space locations with largest information gain:



- GP-algorithm established
 - Mid size problems: 1000 data points, ~50 dimensions
 - many areas of application, ie. fitting of MD-potentials to DFT-data

but...

- Present data base “**insufficient**” ...
 - Physic based line-scans (power, density, temperature...)
 - Does not cover space (eg. approx. Latin hypercube)



- GP-algorithm now in routine application
- Present data base **insufficient**

 Semi-automated data base generation (eg. Bayesian Experimental Design):

- Design Cycle:

- 
- Determine best location(s) for next simulation(s): Utility
 - Recompute uncertainty estimates
 - Check for design criteria: exit?

- GP-algorithm now in routine application
- Present data base **insufficient**

 Semi-automated data base generation (eg. Bayesian Experimental Design):

- Design Cycle:

- 
- Determine best location(s) for next simulation(s): Utility
 - Recompute uncertainty estimates
 - Check for design criteria: exit?
- Challenges: - adequate coverage of relevant input space
 - code convergence

- **Scaling:** N^3 : not yet prohibitive
- **Correlated output**
 - Standard approach: *independent* scalar response variables
Drawback: Prediction not satisfactory: co-variance
 - Difficulty: design of pos. def. **cross**-correlation matrices
- **Phase transitions:** 'global' scale of covariance matrix

- Gaussian Processes are powerful tool for high-dimensional interpolation → fast emulators → UQ
- Analytical formulas for mean and variance → exp. Design
- Best suited for scalar output

- Automated experimental design cycle:
 - works on test cases
 - At present: too much human intervention needed for plasma codes
 - Problems appear solvable

- Correlated output: research and tests ongoing

Thank you!

References

1. O'Hagan, A. (2006). Bayesian analysis of computer code outputs: a tutorial. *Reliability Engineering and System Safety* **91**, 1290-1300.
2. Santner, T. J., Williams, B. J. and Notz, W. I. (2003). *The Design and Analysis of Computer Experiments*. New York: Springer.
3. Rasmussen, C. E., and Williams, C. K. I. (2006). *Gaussian Processes for Machine Learning*. Cambridge, MA: MIT Press.

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